



#### **DUAL N-CHANNEL ENHANCEMENT MODE MOSFET**

#### **Features**

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- ESD Protected Up To 2KV
- Lead Free By Design/RoHS Compliant (Note 1)
- "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

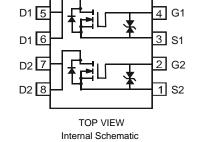
#### **Mechanical Data**

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram Below
- Marking Information: See Page 5
- Ordering Information: See Page 5
- Weight: 0.072 grams (approximate)





TOP VIEW



Maximum Ratings @T<sub>A</sub> = 25°C unless otherwise specified

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			$V_{DSS}$	20	V
Gate-Source Voltage			$V_{GSS}$	±12	V
Continuous Drain Current (Note 3)	Steady State	$T_A = 25$ °C $T_A = 85$ °C	I <sub>D</sub>	9.5 7.1	А
Pulsed Drain Current (Note 4)			I <sub>DM</sub>	30	Α

### **Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 3)	$P_{D}$	1.28	W
Thermal Resistance, Junction to Ambient @T <sub>A</sub> = 25°C (Note 3)	R <sub>θJA</sub>	99.3	°C/W
Operating and Storage Temperature Range	T <sub>.I</sub> , T <sub>STG</sub>	-55 to +150	°C

Notes:

- 1. No purposefully added lead.
- Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com/products/lead\_free/index.php.
   Device mounted on FR-4 PCB, with minimum recommended pad layout.
- 4. Repetitive rating, pulse width limited by junction temperature.

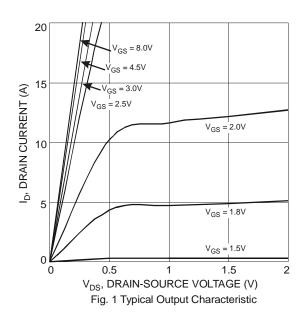


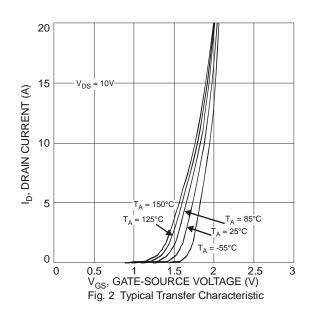
# **Electrical Characteristics** @T<sub>A</sub> = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 5)			-				
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	20	-	-	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current T <sub>J</sub> = 25°C	I <sub>DSS</sub>	-	-	1.0	μΑ	$V_{DS} = 20V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	-	-	±10	μΑ	$V_{GS} = \pm 12V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	$V_{GS(th)}$	0.5	1.0	1.5	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$	
Static Drain-Source On-Resistance	D		11 17	16 23	mΩ	$V_{GS} = 4.5V, I_D = 9.4A$	
Static Diam-Source Off-Resistance	R <sub>DS (ON)</sub>	-				$V_{GS} = 2.5V, I_D = 8.3A$	
Forward Transfer Admittance	Y <sub>fs</sub>	1	17	-	S	$V_{DS} = 5V, I_{D} = 9.4A$	
Diode Forward Voltage	V <sub>SD</sub>	-	0.7	1.2	V	$V_{GS} = 0V, I_{S} = 1.3A$	
DYNAMIC CHARACTERISTICS (Note 6)							
Input Capacitance	C <sub>iss</sub>	1	1149	-	pF	$V_{DS} = 10V, V_{GS} = 0V,$ f = 1.0MHz	
Output Capacitance	Coss	-	157	-	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>	-	142	-	pF		
Gate Resistance	Rg	-	1.51	-	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	$Q_{g}$	-	11.6	-	nC		
Total Gate Charge (V <sub>GS</sub> = 10V)	$Q_g$	-	26	-	nC	$V_{GS} = 4.5V, V_{DS} = 10V,$ $I_{D} = 9.4A$	
Gate-Source Charge	Qgs	-	2.7	-	nC		
Gate-Drain Charge	$Q_{gd}$	-	3.4	-	nC		
Turn-On Delay Time	t <sub>D(on)</sub>	-	11.67	-	ns	$V_{DD} = 10V, V_{GS} = 4.5V,$ $R_{GEN} = 6\Omega, I_D = 1A$	
Turn-On Rise Time	t <sub>r</sub>	-	12.49	-	ns		
Turn-Off Delay Time	t <sub>D(off)</sub>	-	35.89	-	ns		
Turn-Off Fall Time	t <sub>f</sub>	-	12.33	-	ns		

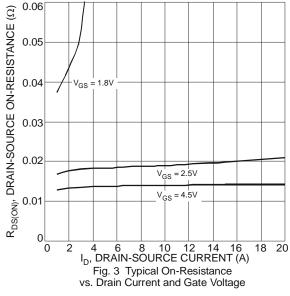
Notes:

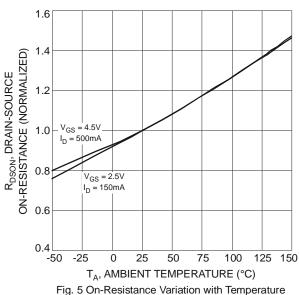
- 5. Short duration pulse test used to minimize self-heating effect.
- 6. Guaranteed by design. Not subject to production testing.

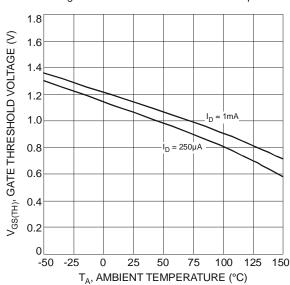


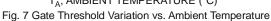


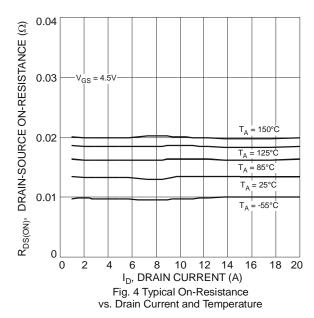


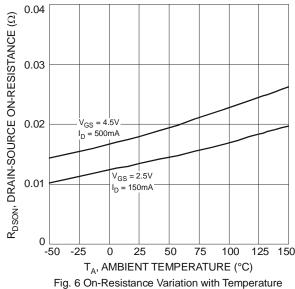












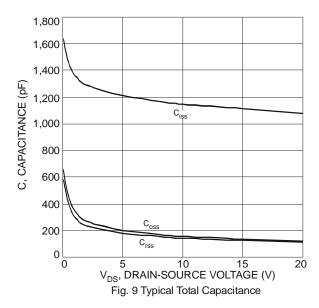
20 IS, SOURCE CURRENT (A) 15 = 25°C 10 5 0 0.4 8.0 1.2

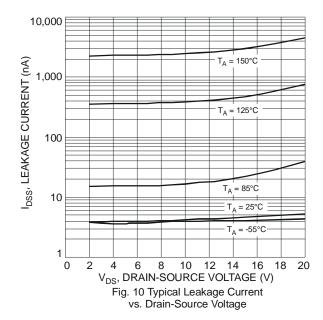
V<sub>SD</sub>, SOURCE-DRAIN VOLTAGE (V)

Fig. 8 Diode Forward Voltage vs. Current

0.6







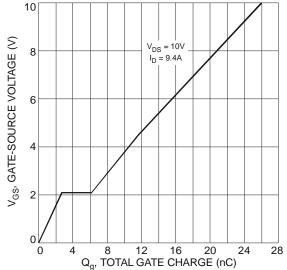


Fig. 11 Gate-Source Voltage vs. Total Gate Charge

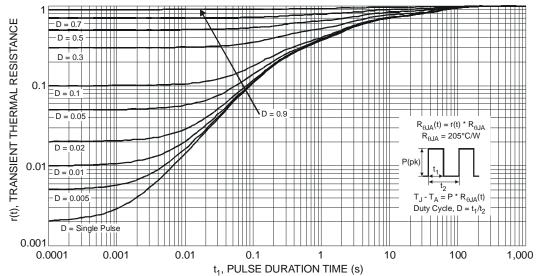


Fig. 12 Transient Thermal Response

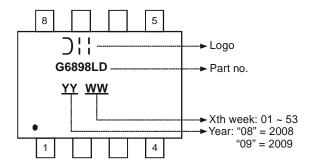


### **Ordering Information** (Note 7)

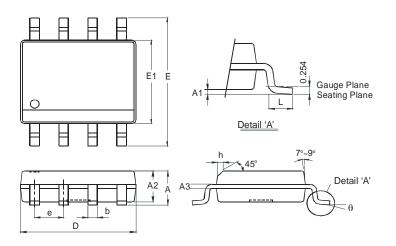
Part Number	Case	Packaging
DMG6898LSD-13	SO-8	2500 / Tape & Reel

Notes: 7. For packaging details, go to our website at http://www.diodes.com/datasheets/ap02007.pdf.

# **Marking Information**

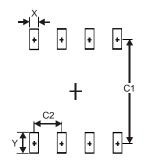


# **Package Outline Dimensions**



SO-8					
Dim	Min	Max			
Α	-	1.75			
A1	0.10	0.20			
A2	1.30	1.50			
А3	0.15	0.25			
b	0.3	0.5			
D	4.85	4.95			
Е	5.90	6.10			
E1	3.85	3.95			
е	e 1.27 Typ				
h	-	0.35			
L	0.62	0.82			
θ	0°	8°			
All Dimensions in mm					

### **Suggested Pad Layout**



Dimensions	Value (in mm)
Х	0.60
Υ	1.55
C1	5.4
C2	1.27



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